MOSFET – Dual, N-Channel, POWERTRENCH®

Q1: 40 V, 156 A, 1.5 mΩ
Q2: 40 V, 156 A, 1.5 mΩ

FDMD8540L

ON Semiconductor®

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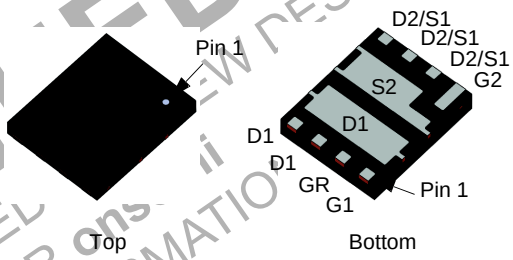
V_{DS}	$r_{DS(ON)}$ MAX	I_D MAX
40 V	1.5 mΩ @ 10 V	156 A
	2.2 mΩ @ 4.5 V	



PQFN8 5X6, 1.27P
Power 5 x 6
CASE 483AT

General Description

This device includes two 40 V N−Channel MOSFETs in a dual Power (5 mm x 6 mm) package. HS source and LS drain internally connected for half/full bridge, low source inductance package, low $r_{DS(on)}$/Qg FOM silicon.

Features

Q1: N−Channel

- Max $r_{DS(on)}$ = 1.5 mΩ at V_{GS} = 10 V, I_D = 33 A
- Max $r_{DS(on)}$ = 2.2 mΩ at V_{GS} = 4.5 V, I_D = 26 A

Q2: N−Channel

- Max $r_{DS(on)}$ = 1.5 mΩ at V_{GS} = 10 V, I_D = 33 A
- Max $r_{DS(on)}$ = 2.2 mΩ at V_{GS} = 4.5 V, I_D = 26 A

- Ideal for Flexible Layout in Primary Side of Bridge Topology
- 100% UIL Tested
- Kelvin High Side MOSFET Drive Pin−out Capability
- This Device is Pb−Free and are RoHS Compliant

Applications

- POL Synchronous Dual
- One Phase Motor Half Bridge
- Half/Full Bridge Secondary Synchronous Rectification

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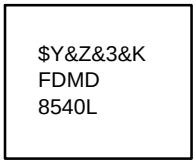
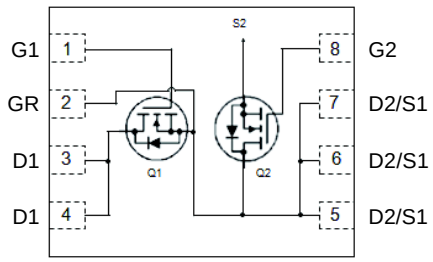
MARKING DIAGRAM



FDMD8540L = Specific Device Code
$Y = ON Semiconductor Logo
&Z = Assembly Plant Code
&3 = 3−Digit Date Code Format
&K = 2−Digits Lot Run Traceability Data



ORDERING INFORMATION

See detailed ordering and shipping information on page 9 of this data sheet.

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MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter			Q1	Q2	Unit
V_{DS}	Drain to Source Voltage			40	40	V
V_{GS}	Gate to Source Voltage			±20	±20	V
I_D	Drain Current	− Continuous	T_C = 25°C (Note 3)	156	156	A
		− Continuous	T_C = 100°C (Note 3)	99	99	
		− Continuous	T_A = 25°C	33 (Note 4a)	33 (Note 4b)	
		− Pulsed	(Note 2)	886	886	
E_{AS}	Single Pulse Avalanche Energy (Note 1)			541	541	mJ
P_D	Power Dissipation		T_C = 25°C	62	62	W
	Power Dissipation		T_A = 25°C	2.3 (Note 4a)	2.3 (Note 4b)	
T_J, T_{STG}	Operating and Storage Junction Temperature Range			−55 to +150		°C

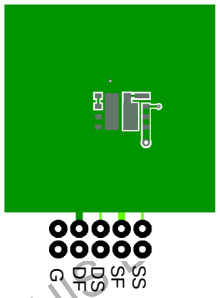
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Q1: E_{AS} of 541 mJ is based on starting T_J = 25°C, L = 3 mH, I_{AS} = 19 A, V_{DD} = 40 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 59 A.
   Q2: E_{AS} of 541 mJ is based on starting T_J = 25°C, L = 3 mH, I_{AS} = 19 A, V_{DD} = 40 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 59 A.
2. Pulsed Id please refer to Figure 11 and Figure 24 SOA graph for more details.
3. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro−mechanical application board design.

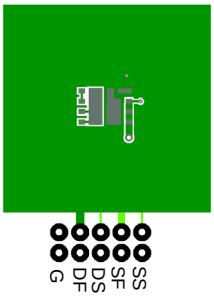
THERMAL CHARACTERISTICS

Symbol	Parameter	Q1	Q2	Unit
$R_{\theta JC}$	Thermal Resistance, Junction−to−Case	2.0	2.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction−to−Ambient	55 (Note 4a)	55 (Note 4b)	

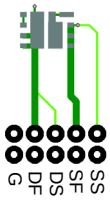
4. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR−4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



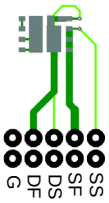
a. 55°C/W when mounted on a 1 in^2 pad of 2 oz copper



b. 55°C/W when mounted on a 1 in^2 pad of 2 oz copper



c. 155°C/W when mounted on a minimum pad of 2 oz copper



d. 155°C/W when mounted on a minimum pad of 2 oz copper

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition		Type	Min	Typ	Max	Unit
OFF CHARACTERISTICS								
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = 250 μA, V_{GS} = 0 V		Q1 Q2	40 40	– –	– –	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 mA, referenced to 25°C		Q1 Q2	– –	20 20	– –	mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 32 V, V_{GS} = 0 V		Q1 Q2	– –	– –	1 1	μA
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±20 V, V_{DS} = 0 V		Q1 Q2	– –	– –	±100 ±100	nA
ON CHARACTERISTICS								
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 250 mA		Q1 Q2	1.0 1.0	1.8 1.8	3.0 3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C		Q1 Q2	– –	−6 −6	– –	mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = 10 V, I_D = 33 A		Q1	–	1.25	1.5	mΩ
		V_{GS} = 4.5 V, I_D = 26 A			–	1.65	2.2	
		V_{GS} = 10 V, I_D = 33 A, T_J = 125°C			–	1.7	2.1	
		V_{GS} = 10 V, I_D = 33 A		Q2	–	1.25	1.5	
		V_{GS} = 4.5 V, I_D = 26 A			–	1.65	2.2	
		V_{GS} = 10 V, I_D = 33 A, T_J = 125°C			–	1.7	2.1	
g_{FS}	Forward Transconductance	V_{DD} = 5 V, I_D = 33 A		Q1 Q2	– –	178 178	– –	S
DYNAMIC CHARACTERISTICS								
C_{iss}	Input Capacitance	V_{DS} = 20 V, V_{GS} = 0 V f = 1 MHz		Q1 Q2	– –	5670 5670	7940 7940	pF
C_{oss}	Output Capacitance			Q1 Q2	– –	1668 1668	2335 2335	pF
C_{rss}	Reverse Transfer Capacitance			Q1 Q2	– –	75 75	135 135	pF
R_g	Gate Resistance			Q1 Q2	0.1 0.1	1.6 1.6	3.2 3.2	Ω
SWITCHING CHARACTERISTICS								
$t_{d(on)}$	Turn−On Delay Time	V_{DD} = 20 V, I_D = 33 A V_{GS} = 10 V, R_{GEN} = 6 Ω		Q1 Q2	– –	15 15	28 28	ns
t_r	Rise Time			Q1 Q2	– –	13 13	24 24	ns
$t_{d(off)}$	Turn−Off Delay Time			Q1 Q2	– –	51 51	81 81	ns
t_f	Fall Time			Q1 Q2	– –	14 14	25 25	ns
$Q_{g(TOT)}$	Total Gate Charge	V_{GS} = 0 V to 10 V	V_{DD} = 20 V, I_D = 33 A	Q1 Q2	– –	81 81	113 113	nC
$Q_{g(TOT)}$	Total Gate Charge	V_{GS} = 0 V to 4.5 V	V_{DD} = 20 V, I_D = 33 A	Q1 Q2	– –	38 38	54 54	nC
Q_{gs}	Gate to Source Charge	V_{DD} = 20 V, I_D = 33 A		Q1 Q2	– –	15 15	– –	nC
Q_{gd}	Gate to Drain “Miller” Charge	V_{DD} = 20 V, I_D = 33 A		Q1 Q2	– –	11 11	– –	nC

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Type	Min	Typ	Max	Unit
DRAIN−SOURCE DIODE CHARACTERISTICS							
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = 33 A (Note 5)	Q1 Q2	− −	0.8 0.8	1.3 1.3	V
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = 2 A (Note 5)	Q1 Q2	− −	0.7 0.7	1.2 1.2	V
t_{rr}	Reverse Recovery Time	I_F = 33 A, di/dt = 100 A/μs	Q1 Q2	− −	54 54	86 86	ns
Q_{rr}	Reverse Recovery Charge		Q1 Q2	− −	38 38	60 60	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %.

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TYPICAL CHARACTERISTICS (Q1 N−CHANNEL)

(T_J = 25°C unless otherwise noted)

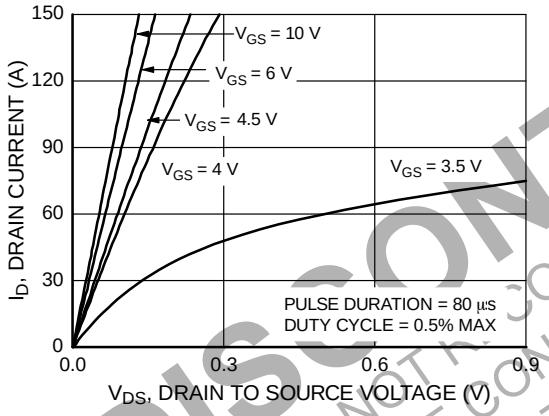

Figure 1. On Region Characteristics

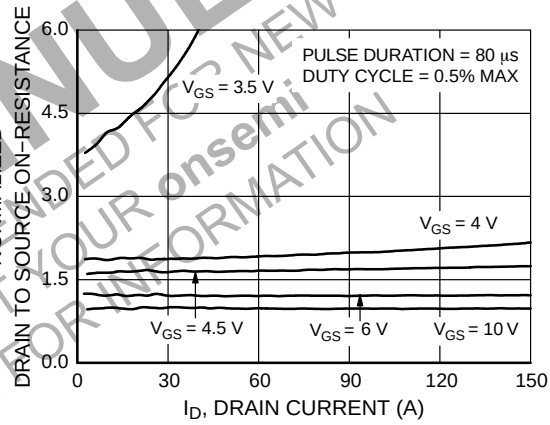

Figure 2. Normalized On−Resistance vs. Drain Current and Gate Voltage

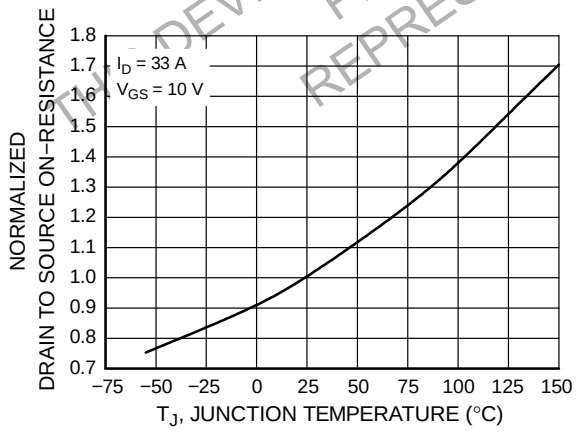

Figure 3. Normalized On Resistance vs. Junction Temperature

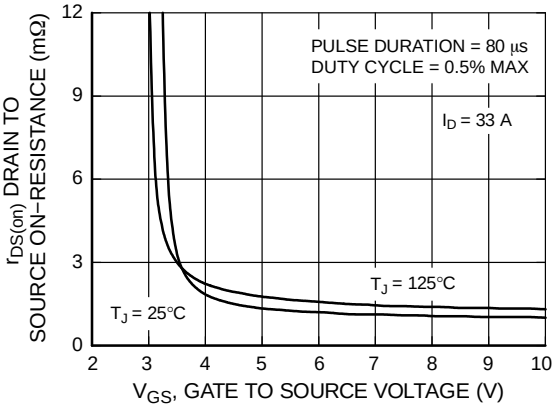

Figure 4. On−Resistance vs. Gate to Source Voltage

TYPICAL CHARACTERISTICS (Q1 N−CHANNEL)

(T_J = 25°C unless otherwise noted) (continued)

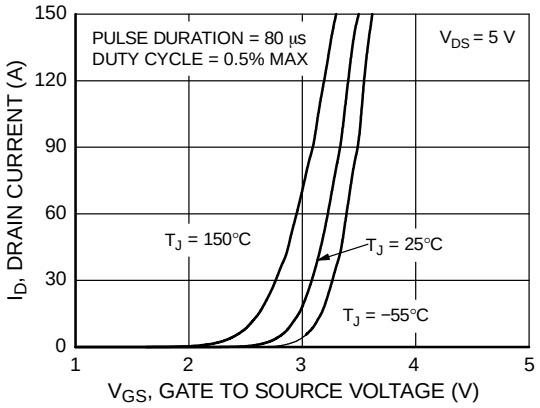

Figure 5. Transfer Characteristics

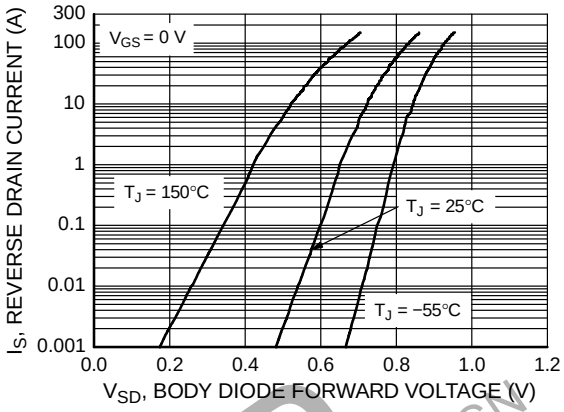

Figure 6. Source to Gate Diode Forward Voltage vs. Source Current

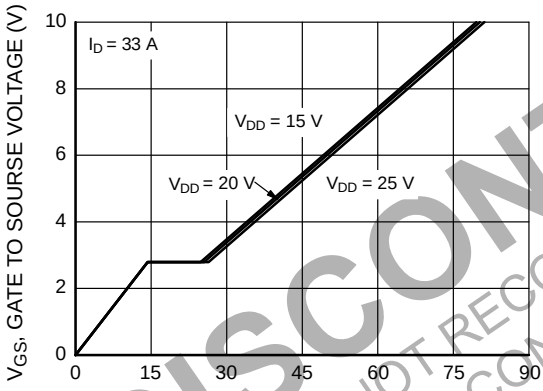

Figure 7. Gate Charge Characteristics

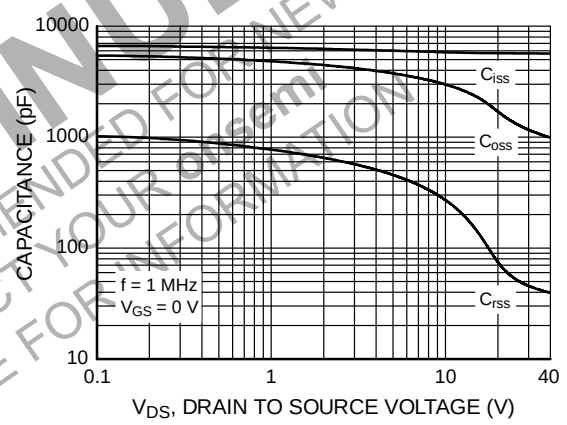

Figure 8. Capacitance vs. Drain to Source Voltage

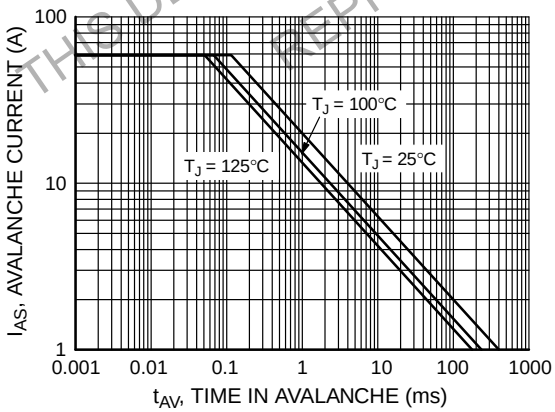

Figure 9. Unclamped Inductive Switching Capability

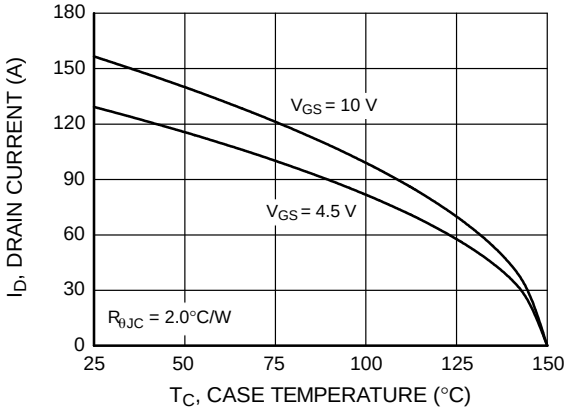

Figure 10. Maximum Continuous Drain Current vs. Case Temperature

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TYPICAL CHARACTERISTICS (Q1 N−CHANNEL)

(T_J = 25°C unless otherwise noted) (continued)

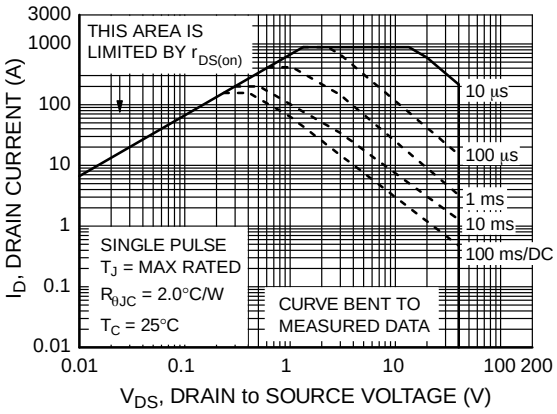

Figure 11. Forward Bias Safe Operating Area

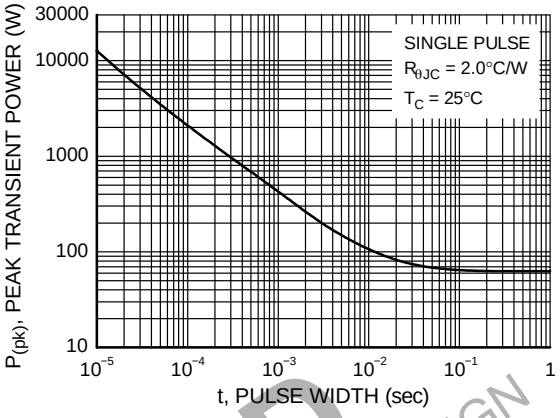

Figure 12. Single Pulse Maximum Power Dissipation

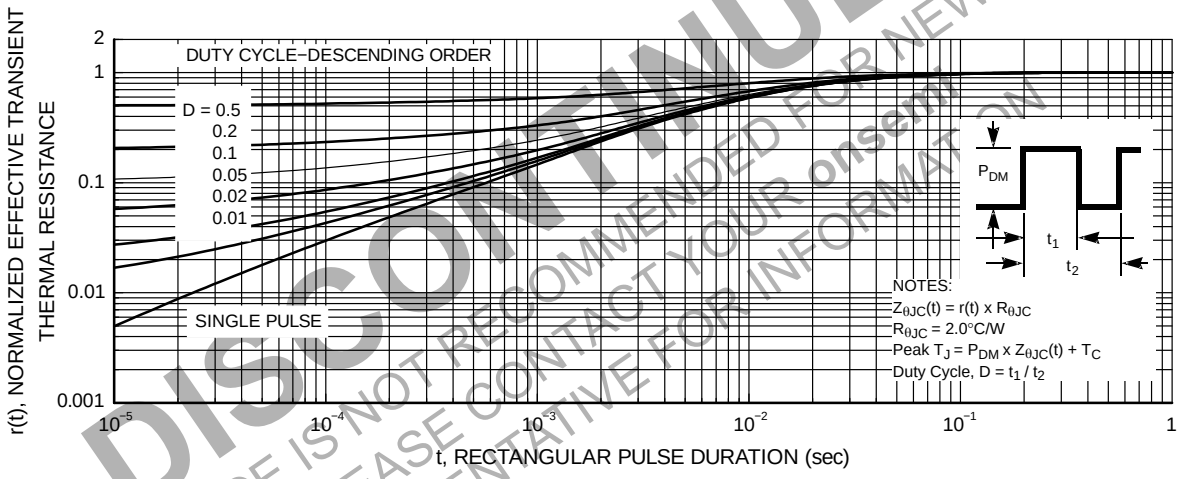

Figure 13. Junction−to−Case Transient Thermal Response Curve

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TYPICAL CHARACTERISTICS (Q2 N−CHANNEL)

(T_J = 25°C unless otherwise noted)

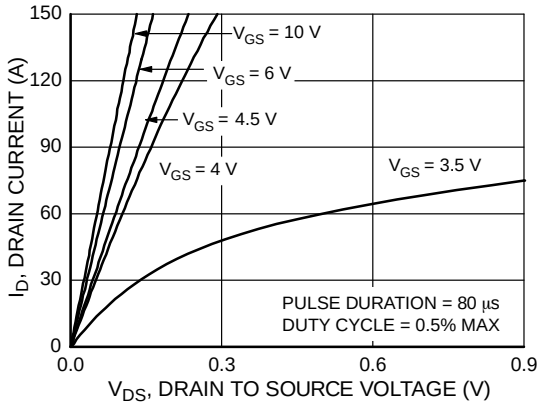

Figure 14. On−Region Characteristics

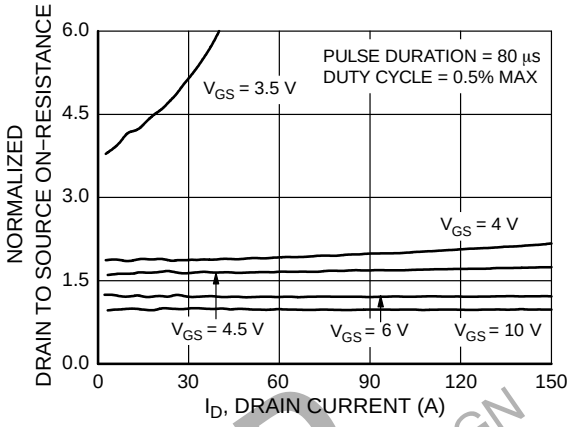

Figure 15. Normalized On−Resistance vs. Drain Current and Gate Voltage

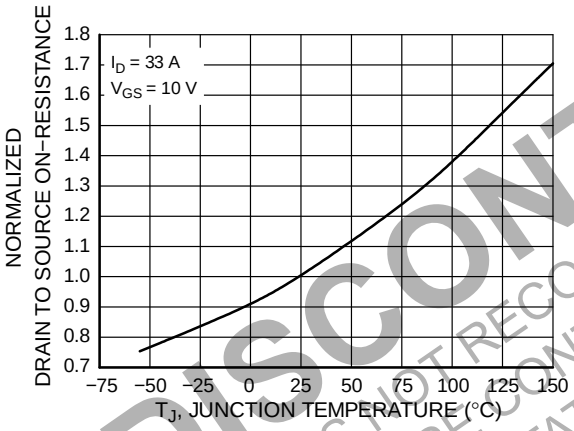

Figure 16. Normalized On Resistance vs. Junction Temperature

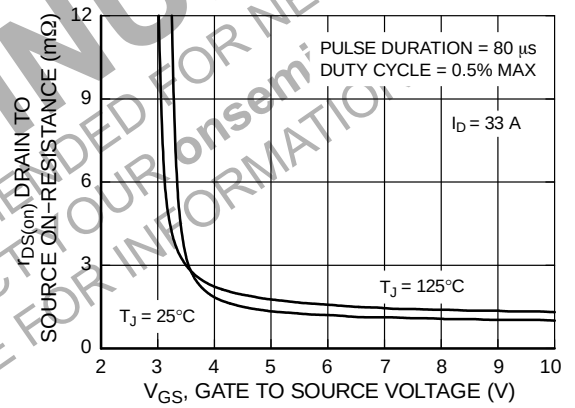

Figure 17. On−Resistance vs. Gate to Source Voltage

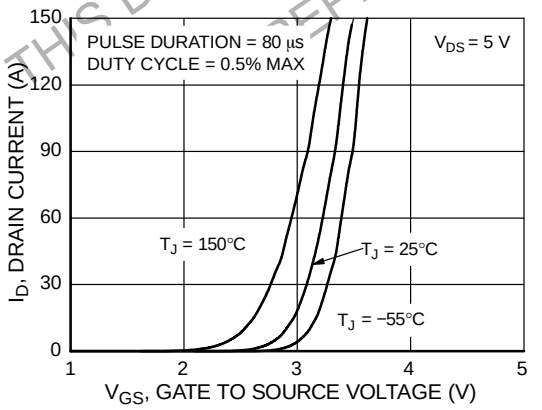

Figure 18. Transfer Characteristics

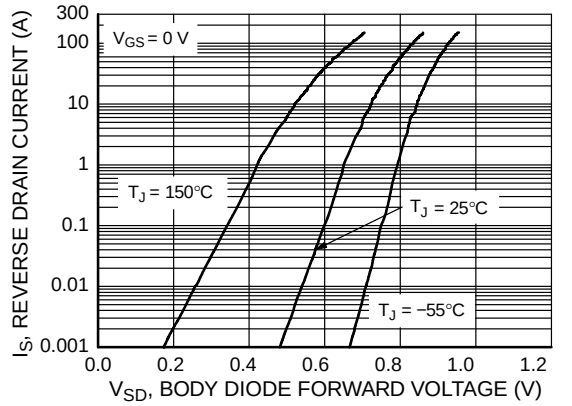

Figure 19. Source to Gate Diode Forward Voltage vs. Source Current

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TYPICAL CHARACTERISTICS (Q2 N−CHANNEL)

(T_J = 25°C unless otherwise noted) (continued)

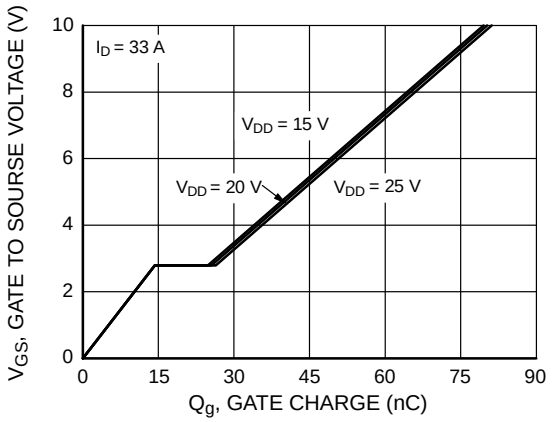

Figure 20. Gate Charge Characteristics

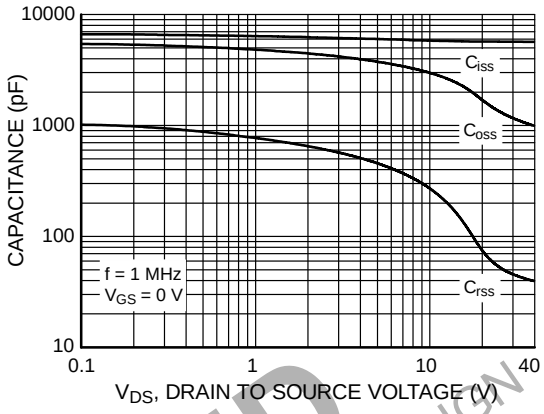

Figure 21. Capacitance vs. Drain to Source Voltage

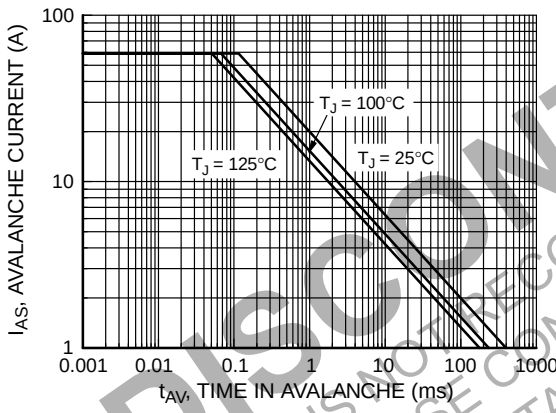

Figure 22. Unclamped Inductive Switching Capability

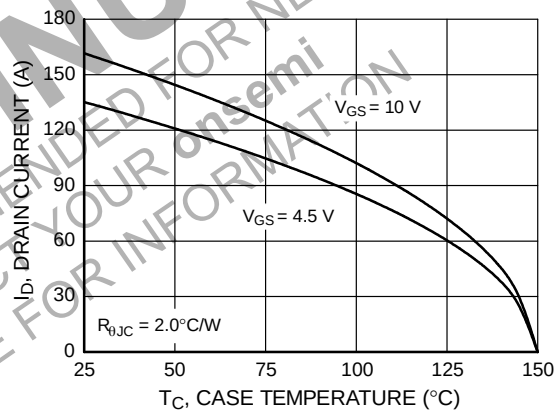

Figure 23. Maximum Continuous Drain Current vs. Case Temperature

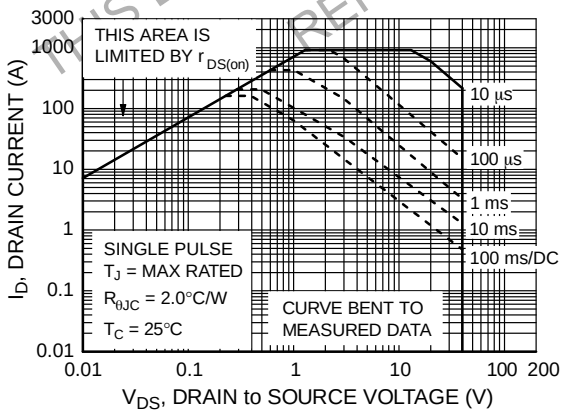

Figure 24. Forward Bias Safe Operating Area

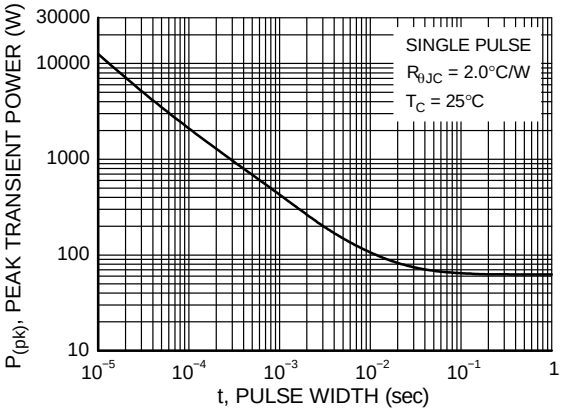

Figure 25. Single Pulse Maximum Power Dissipation

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TYPICAL CHARACTERISTICS (Q2 N−CHANNEL)

(T_J = 25°C unless otherwise noted) (continued)

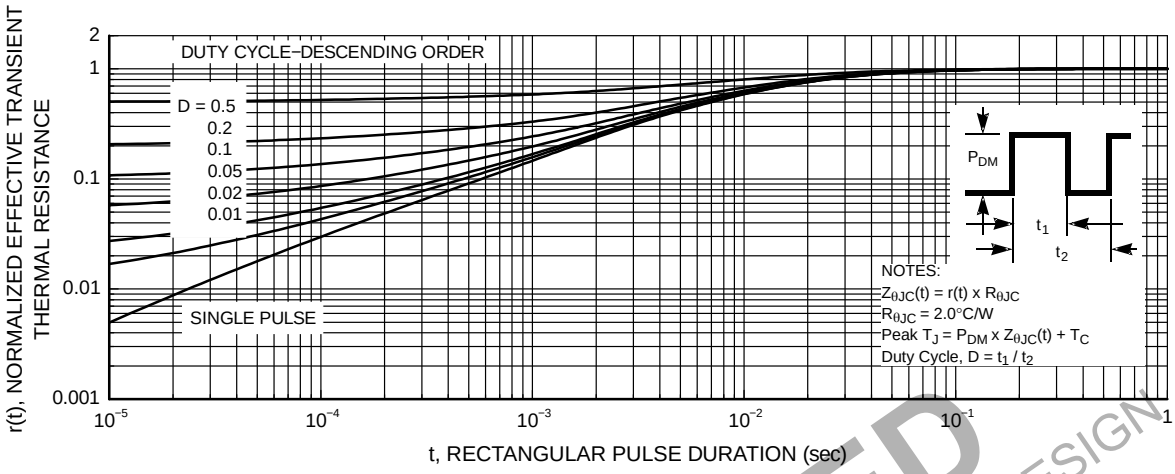

Figure 26. Junction−to−Case Transient Thermal Response Curve

DISCONTINUED
THIS DEVICE IS NOT RECOMMENDED FOR NEW DESIGN.
PLEASE CONTACT YOUR onsemi
REPRESENTATIVE FOR INFORMATION

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package Type	Reel Size	Tape Width	Shipping†
FDMD8540L	FDMD8540L	PQFN8 5X6, 1.27P Power 5 x 6 (Pb−Free)	13"	12 mm	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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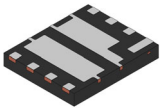
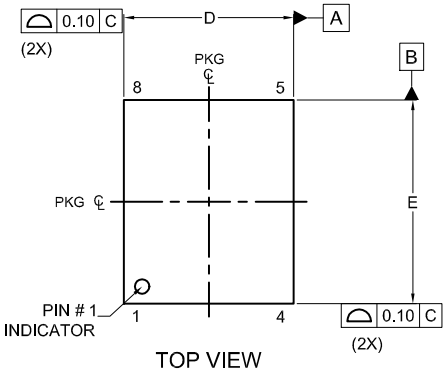
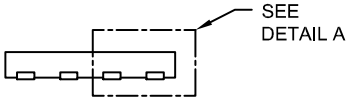


PQFN8 5X6, 1.27P
CASE 483AT
ISSUE B

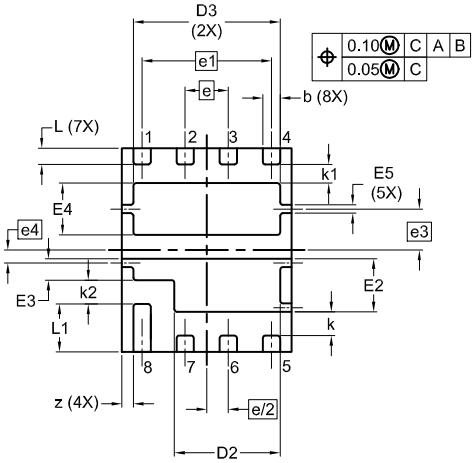
DATE 28 APR 2021



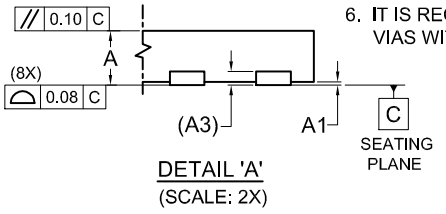
TOP VIEW



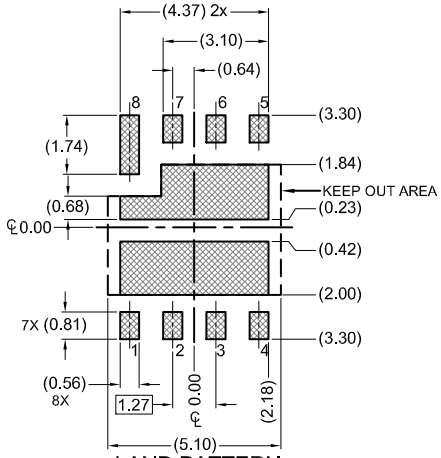
SIDE VIEW



BOTTOM VIEW



DETAIL 'A'
(SCALE: 2X)



LAND PATTERN
RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.70	0.75	0.80
A1	0.00	-	0.05
A3	0.20 REF		
b	0.41	0.51	0.61
D	4.90	5.00	5.10
D2	3.01	3.11	3.21
D3	4.22	4.32	4.42
E	5.90	6.00	6.10
E2	1.47	1.57	1.67
E3	0.53	0.63	0.73
E4	1.42	1.52	1.62
E5	0.20	0.25	0.30
e	1.27 BSC		
e1	3.81 BSC		
e/2	0.64 BSC		
e3	1.08 BSC		
e4	0.25 BSC		
k	0.60	0.70	0.80
k1	0.45	0.55	0.65
k2	0.60	0.70	0.80
L	0.38	0.48	0.58
L1	1.31	1.41	1.51
z	0.34 REF		

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DESCRIPTION:	**PQFN8 5X6, 1.27P**	**PAGE 1 OF 1**

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